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Key indicators

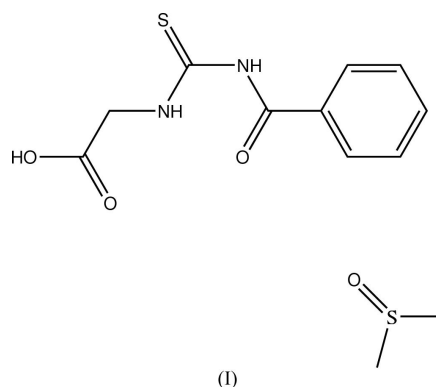
Single-crystal X-ray study
 $T = 298\text{ K}$
Mean $\sigma(\text{C}-\text{C}) = 0.004\text{ \AA}$
 R factor = 0.033
 wR factor = 0.077
Data-to-parameter ratio = 14.8For details of how these key indicators were
automatically derived from the article, see
<http://journals.iucr.org/e>.2-(3-Benzoylthioureido)ethanoic acid
dimethyl sulfoxide solvate

In the title compound, $\text{C}_{10}\text{H}_{10}\text{N}_2\text{O}_3\text{S}\cdot\text{C}_2\text{H}_6\text{SO}$, the ethanoic acid fragment and benzene ring make dihedral angles of $3.61(9)$ and $20.77(9)^\circ$, respectively, with the central thiourea N_2CS group. In the crystal structure, an intermolecular $\text{O}-\text{H}\cdots\text{O}$ hydrogen bond exists between the hydroxy group of the ethanoic acid fragment and the O atom of the dimethyl sulfoxide solvent molecule.

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Comment

The reaction of benzoyl isothiocyanate with β -alanine was found to give the benzoylthiourea derivative of the amino acid 3-(3-benzoylthioureido)propionic acid (Yusof & Yamin, 2003). In the same way, 2-(3-benzoylthioureido)ethanoic acid has been obtained from the reaction with glycine and recrystallized from DMSO (dimethyl sulfoxide) to provide the title compound, (I). The molecule of 2-(3-benzoylthioureido)ethanoic acid maintains the *cis-trans* configuration with respect to the positions of the ethanoic acid and benzoyl groups relative to the thiono $\text{C}=\text{S}$ group across the $\text{C8}-\text{N2}$ and $\text{C8}-\text{N1}$ bonds, respectively (Fig. 1). The geometric dimensions of the molecule (Table 1) are in normal ranges (Allen *et al.*, 1987) and correspond to those observed in 3-(3-benzoylthioureido)propionic acid (Yusof & Yamin, 2003). The central thiourea $\text{S1}/\text{N1}/\text{N2}/\text{C8}$ and ethanoic acid $\text{C9}/\text{C10}/\text{O2}/\text{O3}$ fragments are essentially planar, with maximum deviations of $0.012(2)\text{ \AA}$ (for atom N1) and $0.037(2)\text{ \AA}$ (for atom O3), respectively. The central thiourea fragment makes dihedral angles of $3.61(9)$ and $20.77(9)^\circ$ with the ethanoic acid fragment and phenyl ring, respectively. The dihedral angle between the phenyl ring and ethanoic acid fragment is $17.25(11)^\circ$. There are two intramolecular $\text{N}-\text{H}\cdots\text{O}$ hydrogen bonds (Table 2), resulting in the formation of pseudo-five- and six-membered rings, $\text{N2}-\text{H2A}-\text{O2}-\text{C10}-\text{C9}$ and $\text{N2}-\text{H2A}-\text{O1}-\text{C7}-\text{N1}-\text{C8}$, respectively (Fig. 1).



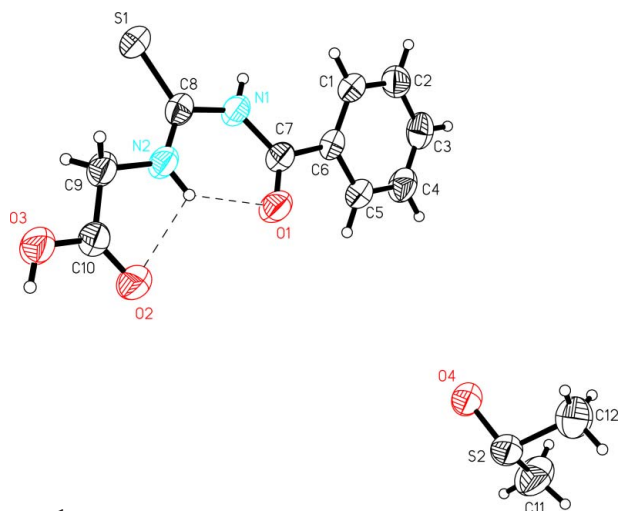


Figure 1
View of (I), with 50% probability displacement ellipsoids. Dashed lines indicate hydrogen bonds.

In the crystal structure, each thiourea molecule interacts with the dimethylsulfoxide solvent molecule *via* an intermolecular O—H···O hydrogen bond (Table 2) between the hydroxy group of the ethanoic acid fragment and the O atom of the dimethyl sulfoxide solvent molecule (Fig. 2).

Experimental

The title compound, (I), was synthesized following the known procedure for the synthesis of benzoylthiourea derivatives (Yusof & Yamin, 2003). Yellow crystals were obtained by recrystallization from DMSO (m.p. 481–482 K). Microelemental analysis found: C 44.9, H 4.76, N 8.69, O 9.4, S 19.6%; calculated: C 45.45, H 5.00, N 8.84, O 10.11, S 20.28%.

Crystal data

$C_{10}H_{10}N_2O_3S \cdot C_2H_6OS$
 $M_r = 316.39$
 Monoclinic, $P2_1$
 $a = 10.074$ (2) Å
 $b = 5.6289$ (12) Å
 $c = 13.969$ (3) Å
 $\beta = 110.074$ (4)°
 $V = 744.0$ (3) Å³
 $Z = 2$

$D_x = 1.412$ Mg m⁻³
 Mo $K\alpha$ radiation
 Cell parameters from 734 reflections
 $\theta = 1.6$ – 26.0 °
 $\mu = 0.37$ mm⁻¹
 $T = 298$ (2) K
 Block, yellow
 $0.44 \times 0.34 \times 0.17$ mm

Data collection

Bruker SMART APEX CCD area-detector diffractometer
 ω scans
 Absorption correction: multi-scan (SADABS; Sheldrick, 1996)
 $T_{\min} = 0.854$, $T_{\max} = 0.940$
 4157 measured reflections

2725 independent reflections
 2537 reflections with $I > 2\sigma(I)$
 $R_{\text{int}} = 0.014$
 $\theta_{\text{max}} = 26.0$ °
 $h = -12 \rightarrow 12$
 $k = -6 \rightarrow 6$
 $l = -15 \rightarrow 17$

Refinement

Refinement on F^2
 $R[F^2 > 2\sigma(F^2)] = 0.033$
 $wR(F^2) = 0.077$
 $S = 1.07$
 2725 reflections
 184 parameters
 H-atom parameters constrained

$w = 1/[\sigma^2(F_o^2) + (0.0359P)^2 + 0.1167P]$
 where $P = (F_o^2 + 2F_c^2)/3$
 $(\Delta/\sigma)_{\text{max}} < 0.001$
 $\Delta\rho_{\text{max}} = 0.19$ e Å⁻³
 $\Delta\rho_{\text{min}} = -0.15$ e Å⁻³
 Absolute structure: Flack (1983), with 1117 Friedel pairs
 Flack parameter: 0.06 (7)

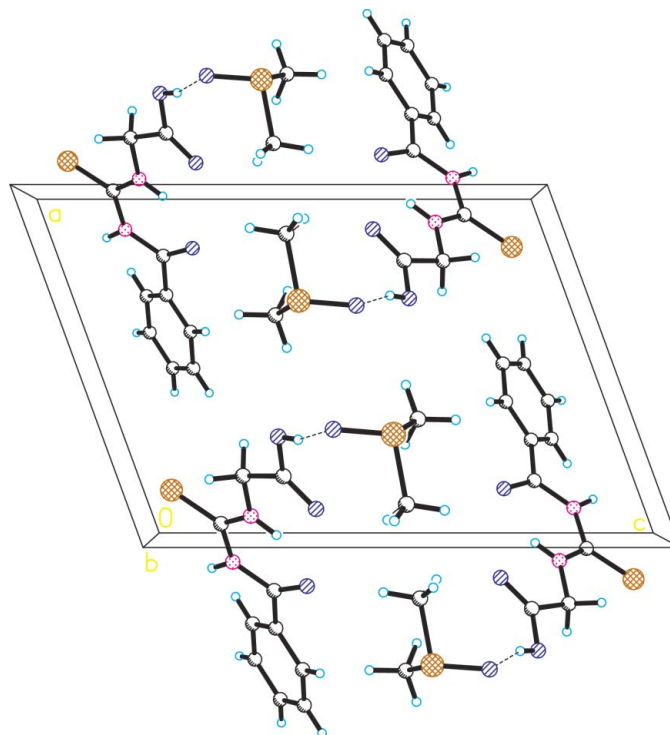


Figure 2
Packing diagram, viewed down the b axis. Dashed lines denote O—H···O hydrogen bonds.

Table 1

Selected interatomic distances (Å).

S1—C8	1.670 (2)	N1—C7	1.381 (3)
O1—C7	1.219 (3)	N1—C8	1.389 (3)
O2—C10	1.206 (3)	N2—C8	1.311 (3)
O3—C10	1.294 (3)	N2—C9	1.444 (3)

Table 2

Hydrogen-bond geometry (Å, °).

$D-H\cdots A$	$D-H$	$H\cdots A$	$D\cdots A$	$D-H\cdots A$
N2—H2A···O1	0.86	1.97	2.645 (3)	134
N2—H2A···O2	0.86	2.35	2.700 (3)	105
O3—H3A···O4 ⁱ	0.82	1.76	2.562 (3)	164

Symmetry code: (i) $x - 1, y + 1, z$.

After their location in a difference Fourier map, all H atoms were positioned geometrically and allowed to ride on their parent atoms, with C—H = 0.93–0.97 Å, O—H = 0.82 Å and N—H = 0.86 Å, and with $U_{\text{iso}}(\text{H}) = 1.2$ – $1.5U_{\text{eq}}(\text{parent atom})$.

Data collection: SMART (Siemens, 1996); cell refinement: SAINT (Siemens, 1996); data reduction: SAINT; program(s) used to solve structure: SHELXTL (Sheldrick, 1997); program(s) used to refine structure: SHELXTL; molecular graphics: SHELXTL; software used to prepare material for publication: SHELXTL, PARST (Nardelli, 1995) and PLATON (Spek, 2003).

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